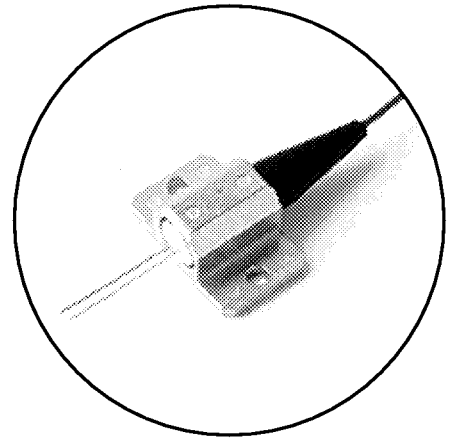


FEATURES

- Multi-mode fiber pigtail
- 30dB Optical Return Loss (ORL)
- 30 μm active area APD
- High reliability planar structure with a guard ring based on advanced InGaAs/InP material technology
- High cut-off frequency (2.5GHz)
- Low dark current
- Low multiplied dark current
- Low excess noise factor

**APPLICATIONS**

- 2.4 Gb/s optical transmission systems

DESCRIPTION

The FPD5W1KS is a wide bandwidth, high sensitivity InGaAs avalanche photodiode (APD) optimized for operation at 1550nm. This APD is designed for use in optical transmission systems operating at a giga-bit-rate, above 2.4Gb/s, and for long transmission distances. The APD chip has a photosensitive area diameter of 30 μm . Fujitsu's advanced InGaAs/InP material technology realizes a high reliability planar structure device with wide bandwidth (large gain-bandwidth product) as well as low noise characteristics. A multi-mode fiber is aligned to a hermetically sealed APD through a highly stable optical coupling system.

ABSOLUTE MAXIMUM RATINGS (T_a=25°C)

| Parameter | Symbol | Ratings | Unit |
|----------------------------|------------------|------------|------|
| Storage Temperature | T _{stg} | -40 to +85 | °C |
| Operating Case Temperature | T _{op} | -40 to +85 | °C |
| Forward Current | I _F | 10 | mA |
| Reverse Current | I _R | 1.0 | mA |

OPTICAL & ELECTRICAL CHARACTERISTICS (T_a=25°C)

| Parameter | Symbol | Limits | | Unit | Conditions | |
|--|------------------|--------|------|------|---|---|
| | | Min. | Max. | | | |
| Responsivity | R | 0.88 | - | A/W | λ=1,550nm | M=1 |
| | | 0.73 | - | A/W | λ=1,310nm | |
| Temperature Dependence of Responsivity | - | -3 | +3 | % | T _a =-20 to +70°C | λ=1,310nm, 1,550nm |
| | | -4 | +4 | | T _a =-40 to +85°C | |
| Breakdown Voltage | V _B | 45 | 65 | V | I _D =10μA | |
| Temperature Coefficient of Breakdown Voltage | γ | 0.09 | 0.15 | V/°C | $\gamma = \frac{\Delta V_B}{\Delta T}$ | |
| Dark Current | I _{D1} | - | 50 | nA | T _a =25°C | V _R =0.9V _B |
| | I _{D2} | - | 0.8 | μA | T _a =70°C | |
| | I _{D3} | - | 1.7 | μA | T _a =85°C | |
| Multiplied Dark Current | I _{DM1} | - | 10 | nA | T _a =25°C | M=1 |
| | I _{DM2} | - | 160 | nA | T _a =70°C | |
| | I _{DM3} | - | 340 | nA | T _a =85°C | |
| Excess Noise Factor | F | - | 6.3 | - | λ=1,310, 1,550nm, M=10, f=30 MHz B=1 MHz, I _{po} =2μA | |
| Cutoff Frequency | f _c | 2.5 | - | GHz | M=5 | λ=1,310, 1,550nm R _L =50Ω -3dB from 500KHZ |
| | | 2.5 | - | | M=10 | |
| | | 1.5 | - | | M=20 | |
| Capacitance | C _t | - | 0.6 | pF | f=1MHz, V _R =0.9V _B | |
| Maximum Multiplication Factor | M _{max} | 30 | - | - | λ=1,310, 1,550nm, I _{po} =2μA | |
| Optical Return Loss | ORL | 30 | - | dB | λ=1,310, 1,550nm | |

Note: Optical characteristics are specified on the condition that single mode fiber is used as the optical source for testing.

Fig. 1 Spectral Response (η vs. λ)

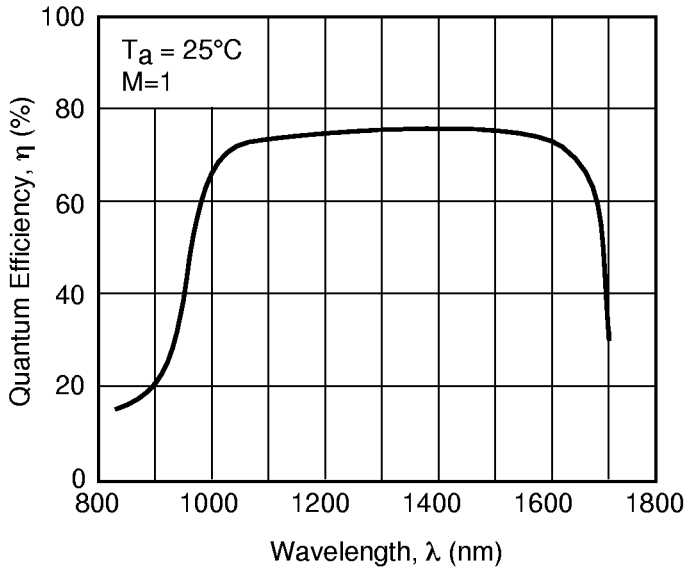


Fig. 2 Spectral Response (R vs. λ)

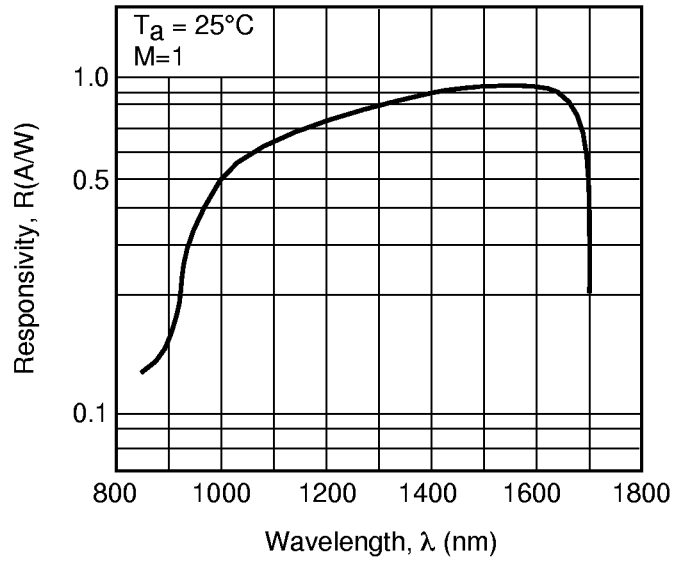


Fig. 3 Temperature Dependence of Responsivity

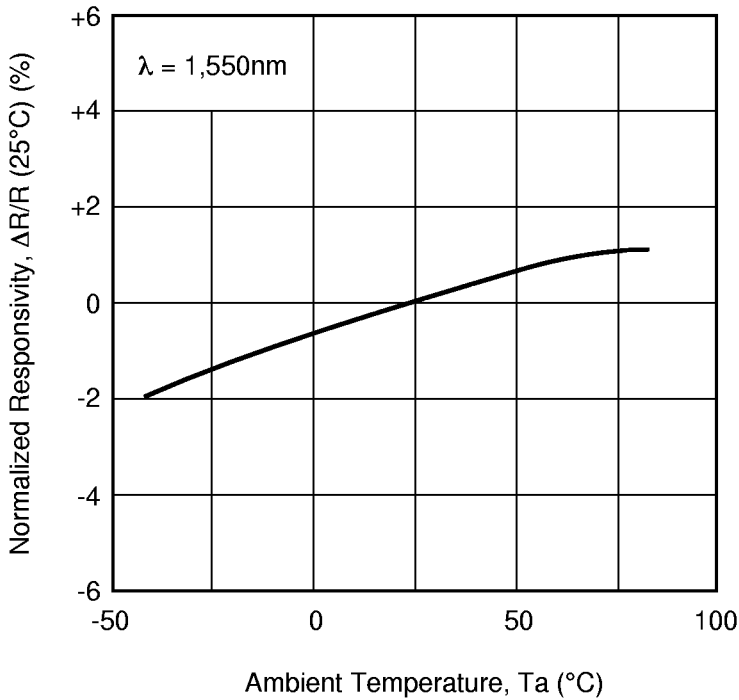


Fig. 4 Dark Current vs. Reverse Voltage

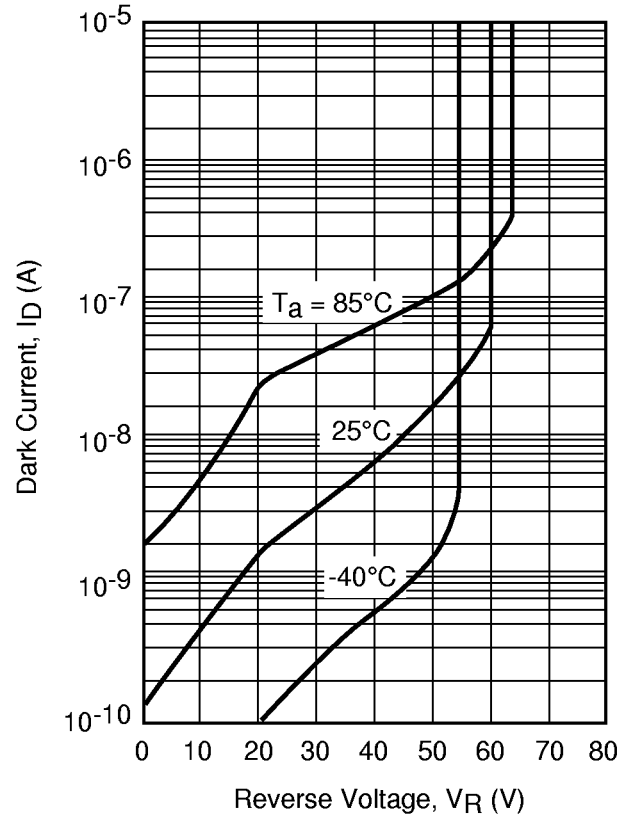


Fig. 5 Temperature Dependence of Dark Current and Multiplied Dark Current

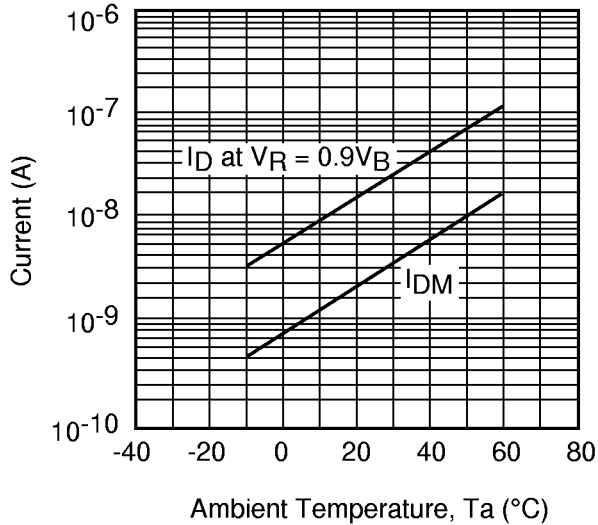


Fig. 6 Multiplication Characteristics

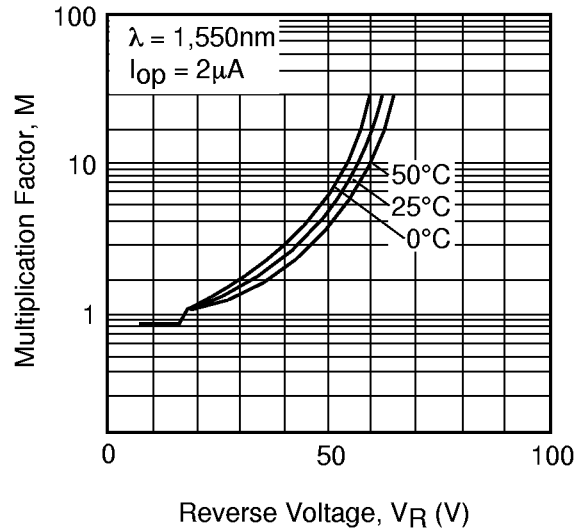


Fig. 7 Multiplication Factor vs. Photocurrent

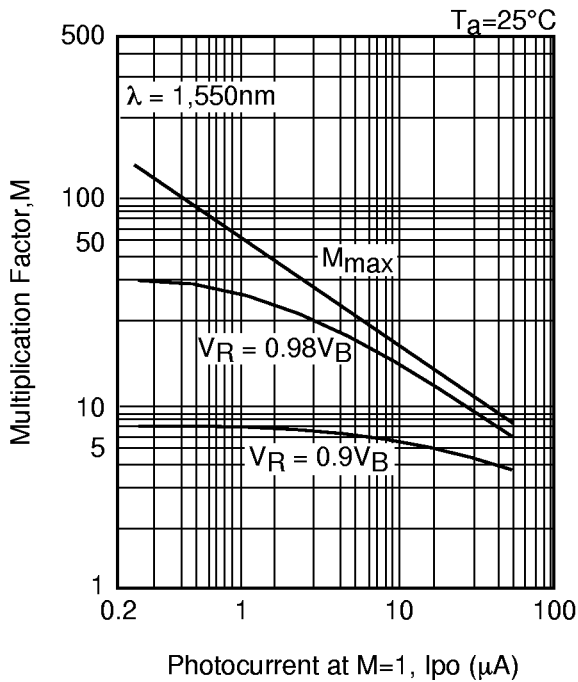


Fig. 8 Frequency Response

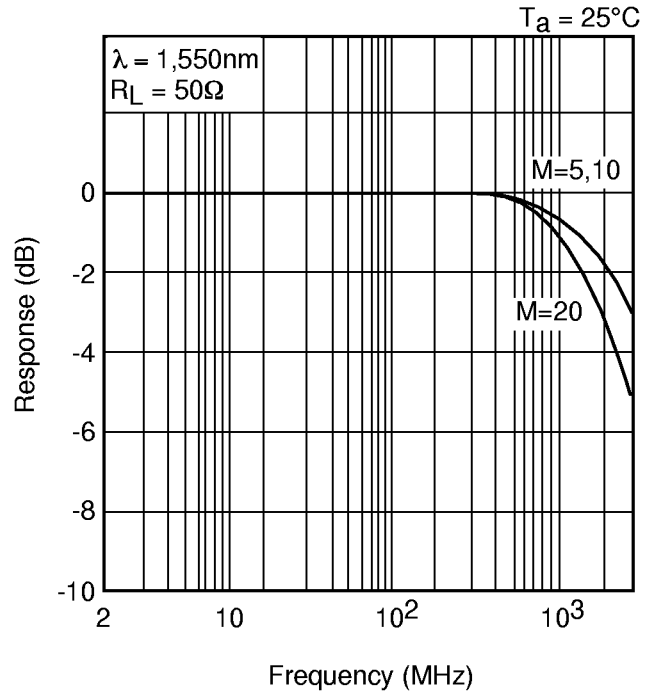


Fig. 9 Cutoff Frequency vs. Multiplication Factor

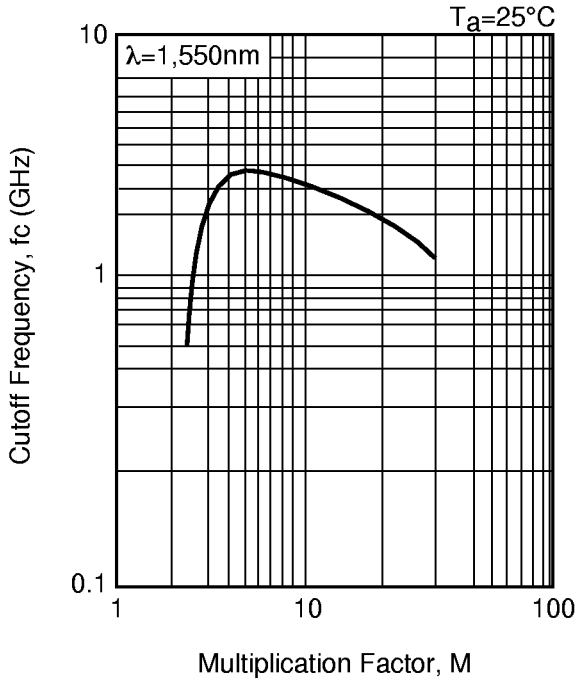


Fig. 10 Excess Noise Factor vs. Multiplication

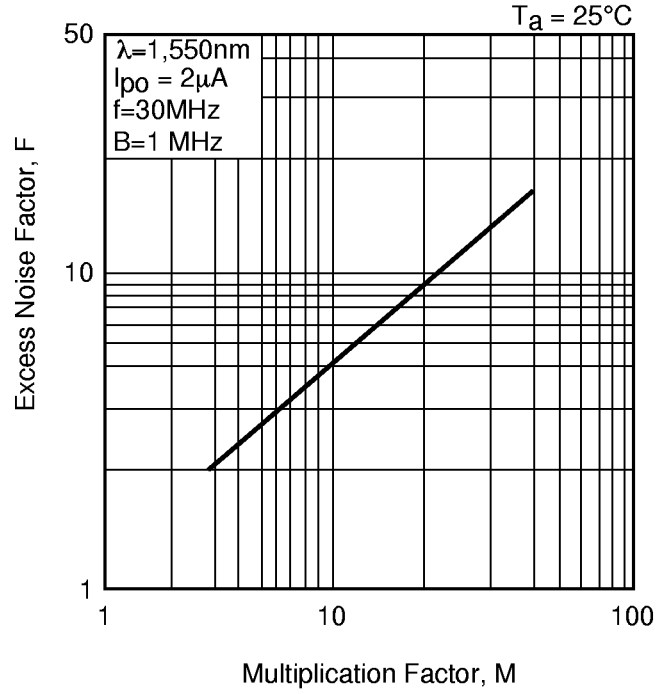
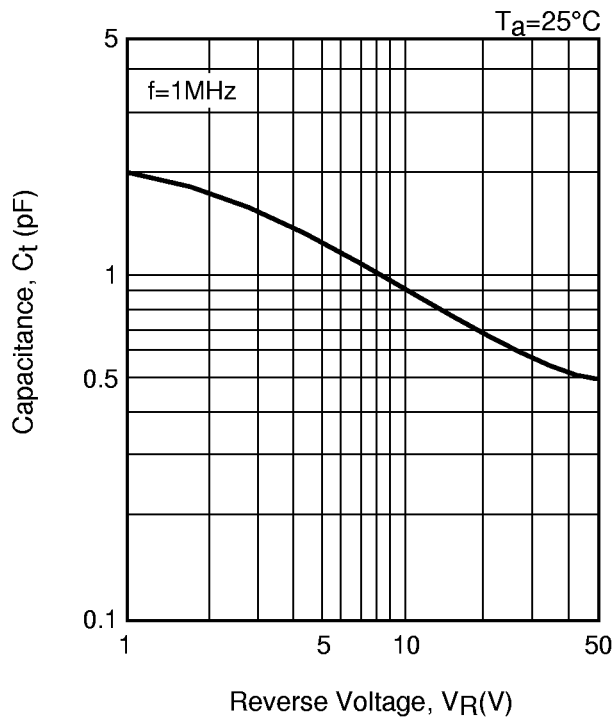
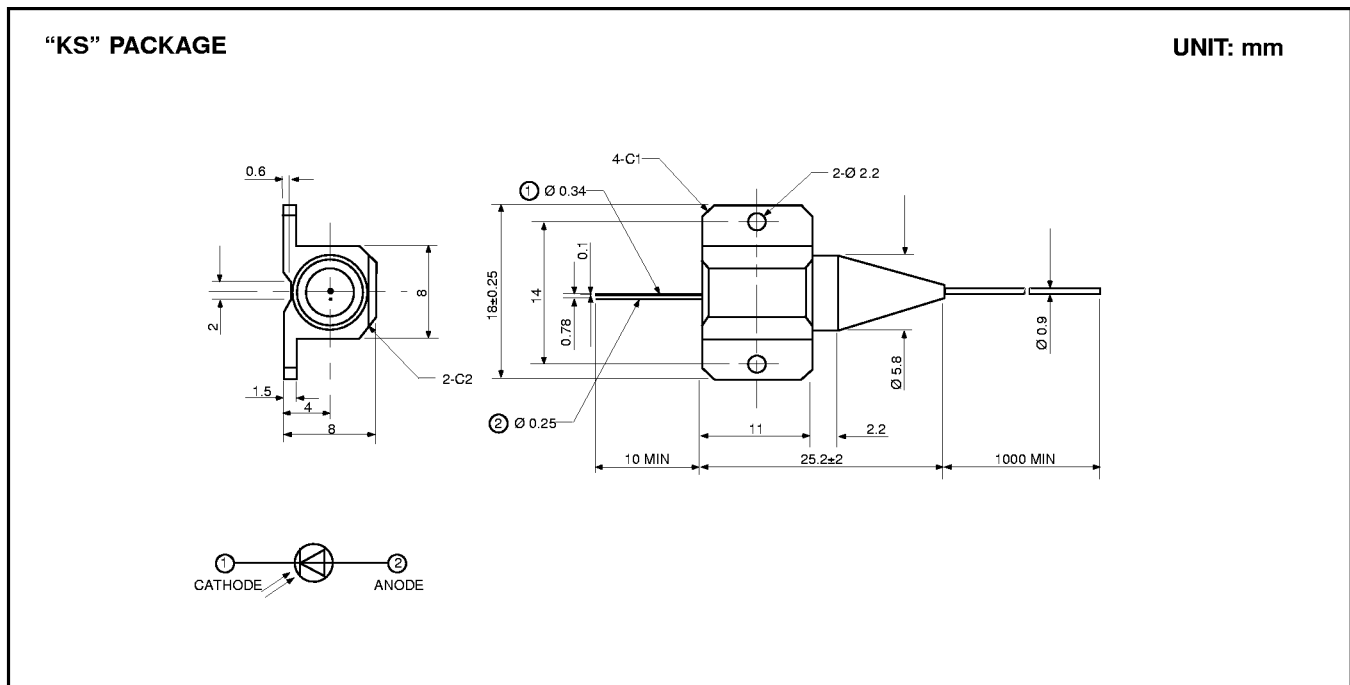


Fig. 11 Capacitance vs. Reverse Voltage





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